

INTERNATIONAL STANDARD



**Fibre optic communication subsystem test procedures –
Part 1-3: General communication subsystems – Measurement of central
wavelength, spectral width and additional spectral characteristics**



THIS PUBLICATION IS COPYRIGHT PROTECTED
Copyright © 2021 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester. If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

IEC Central Office
3, rue de Varembe
CH-1211 Geneva 20
Switzerland

Tel.: +41 22 919 02 11
info@iec.ch
www.iec.ch

About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigendum or an amendment might have been published.

IEC publications search - webstore.iec.ch/advsearchform

The advanced search enables to find IEC publications by a variety of criteria (reference number, text, technical committee, ...). It also gives information on projects, replaced and withdrawn publications.

IEC Just Published - webstore.iec.ch/justpublished

Stay up to date on all new IEC publications. Just Published details all new publications released. Available online and once a month by email.

IEC Customer Service Centre - webstore.iec.ch/csc

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: sales@iec.ch.

IEC online collection - oc.iec.ch

Discover our powerful search engine and read freely all the publications previews. With a subscription you will always have access to up to date content tailored to your needs.

Electropedia - www.electropedia.org

The world's leading online dictionary on electrotechnology, containing more than 22 000 terminological entries in English and French, with equivalent terms in 18 additional languages. Also known as the International Electrotechnical Vocabulary (IEV) online.

Preview generated by EVS

INTERNATIONAL STANDARD



**Fibre optic communication subsystem test procedures –
Part 1-3: General communication subsystems – Measurement of central
wavelength, spectral width and additional spectral characteristics**

INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

ICS 33.180.01

ISBN 978-2-8322-9954-8

Warning! Make sure that you obtained this publication from an authorized distributor.

CONTENTS

FOREWORD	4
1 Scope	6
2 Normative references	6
3 Terms, definitions and abbreviated terms	6
3.1 Wavelength	6
3.2 Spectral width	7
3.3 Additional spectral characteristics	7
3.4 Abbreviated terms	8
4 Apparatus	8
4.1 Calibrated optical spectrum analyzer (OSA)	8
4.2 Calibrated optical wavelength meter (OWM)	8
4.3 Power supplies	9
4.4 Input signal source or modulator	9
4.5 Test cord	9
5 Test sample	9
6 Procedure (method A)	9
6.1 General	9
6.2 Setup	10
6.3 Adjustment of spectrum analyzer controls	10
6.4 Setting of optical wavelength meter	11
7 Procedure (method B)	11
7.1 Setup	11
7.2 Adjustment of spectrum analyzer controls	11
7.3 Setting of optical wavelength meter	11
7.4 Continuous LED and SLM spectra	12
7.5 Discrete MLM spectra	12
7.6 SLM spectra	12
8 Calculation	13
8.1 General	13
8.2 Centre wavelength	13
8.2.1 Continuous LED spectra	13
8.2.2 Discrete MLM spectra	13
8.3 Centroidal wavelength	13
8.4 Peak wavelength	14
8.4.1 Continuous LED and SLM spectra	14
8.4.2 Discrete MLM spectra	14
8.5 RMS spectral width ($\Delta\lambda_{\text{RMS}}$)	14
8.6 <i>n</i> -dB-down spectral width ($\Delta\lambda_{n\text{-dB}}$)	14
8.7 Full-width at half-maximum spectral width ($\Delta\lambda_{\text{fwhm}}$)	14
8.7.1 Continuous LED spectra	14
8.7.2 Discrete MLM spectra	15
8.8 Side-mode suppression ratio (SMSR)	15
8.9 Signal-to-source spontaneous emission ratio (SSER)	15
9 Test results	15
9.1 Required information	15

9.2	Information to be available on request	16
10	Examples of results	16
	Bibliography.....	21
	Figure 1 – Example of a LED optical spectrum.....	16
	Figure 2 – Typical spectrum analyzer output for MLM laser.....	18
	Figure 3 – $\Delta\lambda_{\text{fwhm}}$ spectral width measurement for MLM laser.....	18
	Figure 4 – $\Delta\lambda_{\text{fwhm}}$ spectral width calculation for MLM laser.....	19
	Figure 5 – Peak emission wavelength and $\Delta\lambda_{30\text{-dB}}$ measurement for SLM laser.....	19
	Figure 6 – Resolution bandwidth (RBW) dependence of SMSR for SLM laser	20
	Figure 7 – Signal-to-source spontaneous emission ratio measurement for SLM laser.....	20
	Table 1 – Measurement points for LED spectrum from Figure 1	17
	Table 2 – RMS spectral characterization.....	17

This document is a preview generated by EVS

INTERNATIONAL ELECTROTECHNICAL COMMISSION

FIBRE OPTIC COMMUNICATION SUBSYSTEM TEST PROCEDURES –**Part 1-3: General communication subsystems – Measurement of central wavelength, spectral width and additional spectral characteristics**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

IEC 61280-1-3 has been prepared by subcommittee 86C: Fibre optic systems and active devices, of IEC technical committee 86: Fibre optics. It is an International Standard.

This third edition cancels and replaces the second edition published in 2010. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) addition of measurement of signal-to-source spontaneous emission ratio in 8.9;
- b) change of document title to reflect the additional measurement;
- c) additional information on the resolution bandwidth used in the measurement of the side-mode suppression ratio in 8.8;
- d) use of a calibrated optical wavelength meter for accurate wavelength measurements of single-longitudinal mode lasers.

The text of this International Standard is based on the following documents:

Draft	Report on voting
86C/1701/CDV	86C/1717/RVC

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/standardsdev/publications.

A list of all parts in the IEC 61280 series, published under the general title *Fibre optic communication subsystem test procedures*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under webstore.iec.ch in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

IMPORTANT – The "colour inside" logo on the cover page of this document indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

FIBRE OPTIC COMMUNICATION SUBSYSTEM TEST PROCEDURES –

Part 1-3: General communication subsystems – Measurement of central wavelength, spectral width and additional spectral characteristics

1 Scope

This part of IEC 61280 provides definitions and measurement procedures for several wavelength and spectral width properties of an optical spectrum associated with a fibre optic communication subsystem, an optical transmitter, or other light sources used in the operation or test of communication subsystems. This document also provides definitions and measurement procedures for side-mode suppression ratio and signal-to-source spontaneous emission ratio.

The measurement is done for the purpose of system construction and/or maintenance. In the case of communication subsystem signals, the optical transmitter is typically under modulation.

NOTE Different properties can be appropriate to different spectral types, such as continuous spectra characteristics of light-emitting diodes (LEDs), as well as multilongitudinal-mode (MLM), multitransverse-mode (MTM) and single-longitudinal mode (SLM) spectra, which are characteristic of laser diodes (LDs).

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60825-1, *Safety of laser products – Part 1: Equipment classification and requirements*

IEC 62129-1, *Calibration of wavelength/optical frequency measurement instruments – Part 1: Optical spectrum analyzers*

IEC 62129-2, *Calibration of wavelength/optical frequency measurement instruments – Part 2: Michelson interferometer single wavelength meters*

3 Terms, definitions and abbreviated terms

For the purposes of this document, the following terms, definitions and abbreviated terms apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <http://www.electropedia.org/>
- ISO Online browsing platform: available at <http://www.iso.org/obp>

3.1 Wavelength

NOTE The following wavelength terms provide quantitative definitions for the description of the central wavelength of a spectrum. In this document, "central wavelength" is a general category label for these terms.